

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT					ATTY DOCKET NO.				L NO.				
					SJO9-2000-0009US1				Unassigned 09/944, 648				
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					Dinan et al.								
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			U.S.	PATEN	T DOCU	MENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME			CLASS	SUBCLASS		FILING DATE IF APPROPRIATE			
Chi	AA	5,282,308	2/1994	Chen et al.			29	603 . / 5	?	A	OIMATE	·	
	AB	5,285,340	2/1994	Ju et al.			360	119					
	AC	5,774,308	6/1998	Ohtsuka et al.		360	126						
	AD	5,805,391	9/1998	Chang et al.		360	713 س		-		·		
Chr	AE	6,043,960	3/2000	Chang	Chang et al.		360	126 317					
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			FOREIG	N PATE	NT DOC	UMENT	s		·				
	T	DOCUMENT NUMBER	DATE	COUNT	COUNTRY		NAME		SUBCI	ASS		LATION	
Ch	AL	JP 57078613A	5/1982	Japan	Japan Canon		nc		† _		YES	NO	
Ch	AM	JP 01267812A	1/1989	Japan		TDK Corp			<u> </u>	ш.			
Clin	AN	JP 03228210A	1/1991		Japan F		Fujitsu Ltd		T -				
	АО										†		
	AP								† –		ļ		
		OTHER DOCUM	MENTS (Incl	uding Aı	ıthor, Tit	le, Date,	Pertinent I	Pages, Etc.))		L		
$\sim l$	AQ	IBM Technic for Horizonta	IBM Technical Disclosure Bulletin, Vol. 40 No. 04, April 1997, entitled: Sidewall Formation Using Silicon Nitride Mask for Horizontal/Planar Magnetic Heads										
the	AR	IBM Technic Heads	al Disclosure Bi	e Bulletin, Vol 40 No. 04, April 1997, entitled: Sidewall Process for Horizontal/Planar Magnetic									
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		hen Jin	i					£ /02/03					
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.													
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(Form PTO-1449) SV: 208670 v01 05/16/2001